International IOR Rectifier

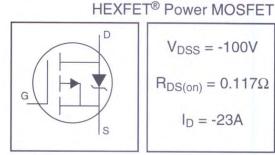
IRF9540NPbF

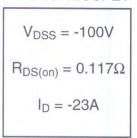
- Lead-Free
- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- P-Channel
- Fully Avalanche Rated

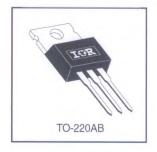
Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.







Absolute Maximum Ratings

| | Parameter | Max. | Units |
|--|--|------------------------|-------|
| © T _C = 25°C Continuous Drain Current, V _{GS} @ -10V | | -23 | |
| I _D @ T _C = 100°C | Continuous Drain Current, V _{GS} @ -10V | -16 | A |
| I _{DM} | Pulsed Drain Current ① | -76 | |
| P _D @T _C = 25°C | Power Dissipation | 140 | W |
| | Linear Derating Factor | 0.91 | W/°C |
| V _{GS} | Gate-to-Source Voltage | ± 20 | V |
| E _{AS} | Single Pulse Avalanche Energy® | 430 | mJ |
| I _{AR} | Avalanche Current① | -11 | A |
| E _{AR} | Repetitive Avalanche Energy® | 14 | mJ |
| dv/dt | Peak Diode Recovery dv/dt 3 | -5.0 | V/ns |
| TJ | Operating Junction and | -55 to + 175 | |
| T _{STG} | Storage Temperature Range | | °C |
| | Soldering Temperature, for 10 seconds | 300 (1.6mm from case) | |
| | Mounting torque, 6-32 or M3 srew | 10 lbf•in (1.1N•m) | |

Thermal Resistance

| | Parameter | Тур. | Max. | Units |
|--------------------------------------|-------------------------------------|------|------|-------|
| R _{eJC} | Junction-to-Case | _ | 1.1 | °C/W |
| R _{θCS} | Case-to-Sink, Flat, Greased Surface | 0.50 | _ | |
| R _{BJA} Junction-to-Ambient | | _ | 62 | |

IRF9540NPbF

Electrical Characteristics @ $T_J = 25$ °C (unless otherwise specified)

| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|--|--------------------------------------|--------------------------------|-------|------------------------|-------|--|
| V _{(BR)DSS} | Drain-to-Source Breakdown Voltage | -100 | _ | | V | $V_{GS} = 0V, I_D = -250\mu A$ |
| ΔV _{(BR)DSS} /ΔT _J | Breakdown Voltage Temp. Coefficient | _ | -0.11 | _ | V/°C | Reference to 25°C, I _D = -1mA |
| R _{DS(on)} | Static Drain-to-Source On-Resistance | _ | _ | 0.117 | Ω | V _{GS} = -10V, I _D = -11A ④ |
| V _{GS(th)} | Gate Threshold Voltage | -2.0 | _ | -4.0 | ٧ | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ |
| 9fs | Forward Transconductance | 5.3 | _ | _ | S | $V_{DS} = -50V, I_{D} = -11A$ |
| I _{DSS} | Drain-to-Source Leakage Current | _ | _ | -25 | | $V_{DS} = -100V, V_{GS} = 0V$ |
| | | _ | | -250 | μА | V _{DS} = -80V, V _{GS} = 0V, T _J = 150°C |
| | Gate-to-Source Forward Leakage | - | _ | 100 | | V _{GS} = 20V |
| I _{GSS} | Gate-to-Source Reverse Leakage | to-Source Reverse Leakage —100 | nA | V _{GS} = -20V | | |
| Qg | Total Gate Charge | _ | _ | 97 | | I _D = -11A |
| Q _{gs} | Gate-to-Source Charge | | _ | 15 | nC | $V_{DS} = -80V$ |
| Q _{qd} | Gate-to-Drain ("Miller") Charge | _ | _ | 51 | | V _{GS} = -10V, See Fig. 6 and 13 @ |
| t _{d(on)} | Turn-On Delay Time | _ | 15 | _ | | V _{DD} = -50V |
| tr | Rise Time | | 67 | _ | | I _D = -11A |
| t _{d(off)} | Turn-Off Delay Time | | 51 | | ns | $R_G = 5.1\Omega$ |
| t _f | Fall Time | | 51 | _ | | $R_D = 4.2\Omega$, See Fig. 10 ④ |
| L _D | Internal Drain Inductance | | 4.5 | _ | | Between lead, 6mm (0.25in.) |
| L _S | Internal Source Inductance | _ | 7.5 | _ | nH | from package and center of die contact |
| C _{iss} | Input Capacitance | _ | 1300 | _ | | V _{GS} = 0V |
| Coss | Output Capacitance | _ | 400 | _ | pF | $V_{DS} = -25V$ |
| Crss | Reverse Transfer Capacitance | _ | 240 | _ | | f = 1.0MHz, See Fig. 5 |

Source-Drain Ratings and Characteristics

| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|-----------------|---|--|------|------|-------|---|
| Is | Continuous Source Current (Body Diode) | | _ | -23 | А | MOSFET symbol showing the |
| I _{SM} | Pulsed Source Current (Body Diode) ① | | _ | -76 | A . | integral reverse p-n junction diode. |
| V _{SD} | Diode Forward Voltage | _ | _ | -1.6 | V | $T_J = 25^{\circ}C$, $I_S = -1 IA$, $V_{GS} = 0V$ ④ |
| t _{rr} | Reverse Recovery Time | | 150 | 220 | ns | $T_J = 25^{\circ}C$, $I_F = -11A$ |
| Q _{rr} | Reverse RecoveryCharge | _ | 830 | 1200 | nC | di/dt = -100A/µs ④ |
| ton | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D) | | | | |

Notes

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting $T_J = 25^{\circ}C$, L = 7.1 mH $R_G = 25\Omega$, $I_{AS} = -11A$. (See Figure 12)
- 4 Pulse width \leq 300 μ s; duty cycle \leq 2%.

IRF9540NPbF

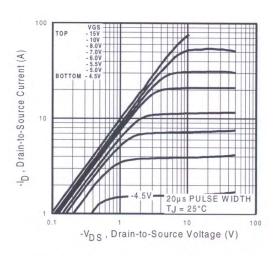
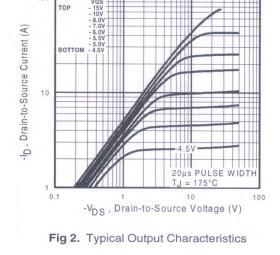


Fig 1. Typical Output Characteristics



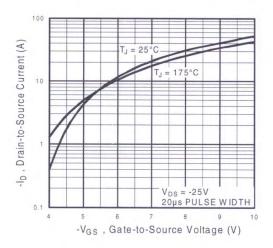


Fig 3. Typical Transfer Characteristics

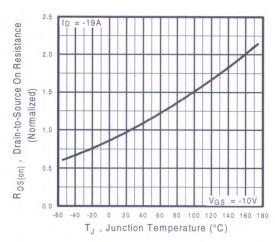


Fig 4. Normalized On-Resistance Vs. Temperature

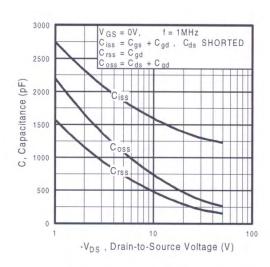


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

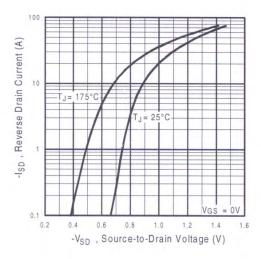


Fig 7. Typical Source-Drain Diode Forward Voltage

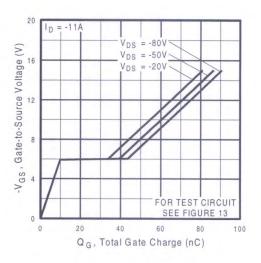


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

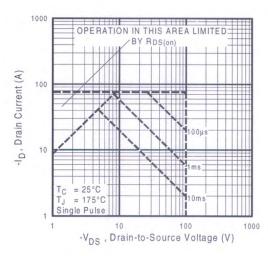


Fig 8. Maximum Safe Operating Area

IRF9540NPbF

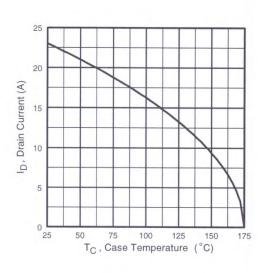


Fig 9. Maximum Drain Current Vs. Case Temperature

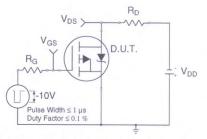


Fig 10a. Switching Time Test Circuit

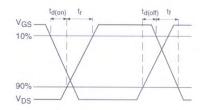


Fig 10b. Switching Time Waveforms

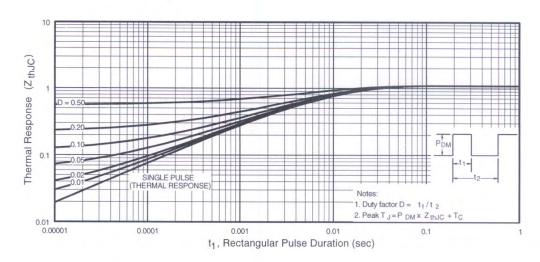


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

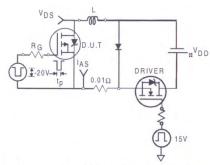


Fig 12a. Unclamped Inductive Test Circuit

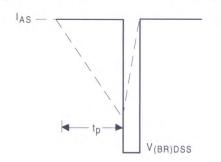


Fig 12b. Unclamped Inductive Waveforms

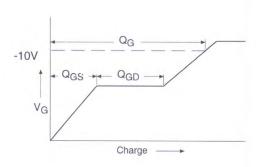


Fig 13a. Basic Gate Charge Waveform

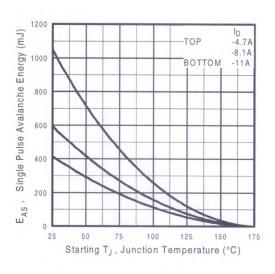


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

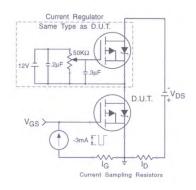
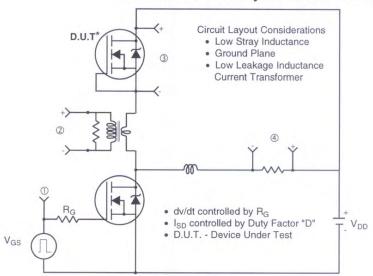
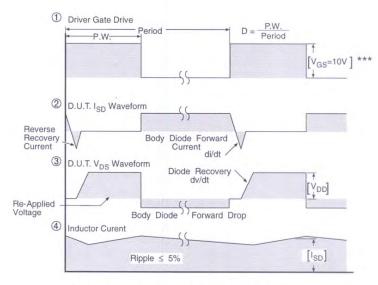


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



* Reverse Polarity of D.U.T for P-Channel

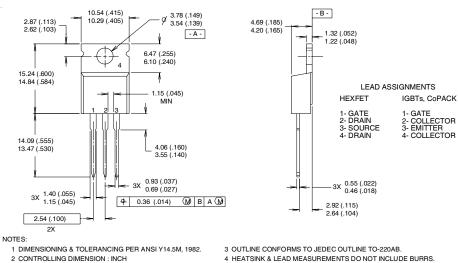


*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

Fig 14. For P-Channel HEXFETS

TO-220AB Package Outline

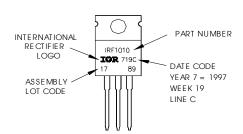
Dimensions are shown in millimeters (inches)



TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010 LOT CODE 1789 ASSEMBLED ON WW 19, 1997 IN THE ASSEMBLY LINE "C" Note: "P" in assembly line

position indicates "Lead-Free



Data and specifications subject to change without notice.



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105 TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.01/04

Note: For the most current drawings please refer to the IR website at: http://www.irf.com/package/

IMPORTANT NOTICE

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (www.infineon.com).

WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Infineon: